

Docket No.: SON-2313

(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Satoshi Ikeda

Application No.: 10/052,736

52,736 Confirmation No.: 3283

Filed: January 23, 2002 Art Unit: 2138

For: SEMICONDUCTOR TESTING APPARATUS

AND METHOD

Examiner: J. C. Kerveros

NOTICE OF APPEAL

MS Appeal Brief - Patents Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Applicant hereby appeals to the Board of Patent Appeals and Interferences from the Office Action dated <u>February 7, 2007</u> of the Examiner rejecting claims 3 and 6-32.

The Office Action of <u>February 7, 2007</u> reopened prosecution prior to a decision on the merits by the Board of Patent Appeals and Interferences. Accordingly, please apply the fee paid on <u>March 30, 2005</u> for the Notice of Appeal. M.P.E.P. §1204.01.

No additional fee to the Patent and Trademark Office for this Notice of Appeal is believed to be required. But if any fee is required or any overpayment made, the Commissioner is hereby authorized to charge the fee or credit the overpayment to Deposit Account # 18-0013.

Dated: April 12, 2007

Respectfully submitted,

Ronald P. Kananen

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